

_	Application No.	Applicant(s)
	10/014,806	CHAVIN, JEAN GUY
	Examiner	Art Unit
	David C. Payne	2633

SEARCHED				
<del> </del>	SEARCHED			
Class	Class Subclass Date		Examiner	
398	1, 2, 31, 33, 34, 56, 9, 8	10/28/2004	DCP	
398	112, 14	10/28/2004	DCP	
398	2, 202	10/28/2004	DCP	
398	154, 156	10/28/2004	DCP	
395	35,5G	10/28/04	Dep	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
398	55,56	1/23/06	DUP
398	33	11	/
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East, see search notes	10/28/2004	DCP
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Search Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/014,806	CHAVIN, JEAN GUY	
Examiner	Art Unit	
David C. Payne	2638	

SEARCHED				
Class	Subclass	Date	Examiner	
370	241.1, 244, 252, 253	8/7 <i>/</i> 2005	DCP	
398	45, 46	8/7 <i>1</i> 2005	DCP	
398	25, 27	8/7/2005		
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ראו	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
370/241.1, 244, 252, 253 (USPGPUB, USPAT)	8/7/2005	DCP
398/45, 46, 25, 27 (USPGPUB, USPAT)	8/7/2005	DCP
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